

Notice of References Cited	Application/Control No. 10/067,310	Applicant(s)/Patent Under Reexamination FUJII ET AL.	
	Examiner Ba Huynh	Art Unit 2179	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0071540	06-2002	Dworkin, David S.	379/202.01
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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